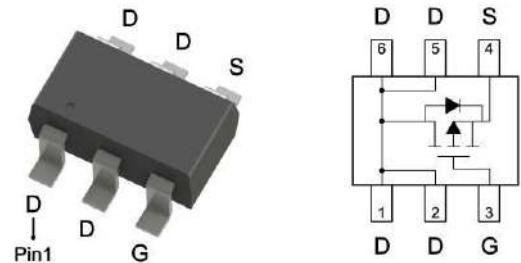


P-Channel Enhancement Mode Power MOSFET

Features :

- Low Gate Charge
- Fast Switching Characteristic
- Pb-free lead plating and halogen-free

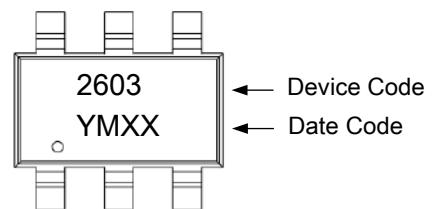
SOT-26



Ordering Information

| Device | Package | Shipping |
|-----------|---------|-----------------------|
| KTTP2603N | SOT-26 | 3000pcs / Tape & Reel |

Marking



YM: Date Code Marking

Y: Year Code, the last digit of Christian year

M: Month Code

| | | | | | |
|--------|--------|--------|--------|--------|--------|
| A: Jan | B: Feb | C: Mar | D: Apr | E: May | F: Jun |
| G: Jul | H: Aug | J: Sep | K: Oct | L: Nov | M: Dec |

XX: Production Serial Number, 01~99

Absolute Maximum Ratings ($T_A=25^\circ\text{C}$)

| Parameter | | Symbol | Value | Unit |
|---|------------------------|-----------------|----------|------|
| Drain-Source Voltage | | V_{DS} | -20 | V |
| Gate-Source Voltage | | V_{GS} | ± 8 | |
| Continuous Drain Current @ $V_{GS}=-4.5\text{V}$, $T_A=25^\circ\text{C}$ | *a | I_D | -5 | A |
| Continuous Drain Current @ $V_{GS}=-4.5\text{V}$, $T_A=70^\circ\text{C}$ | *a | | -4 | |
| Pulsed Drain Current | *b | I_{DM} | -20 | A |
| Continuous Body Diode Forward Current @ $T_A=25^\circ\text{C}$ | *a | I_S | -1.2 | |
| Pulsed Body Diode Forward Current @ $T_A=25^\circ\text{C}$ | *a | I_{SM} | -4.8 | W |
| Total Power Dissipation | $T_A=25^\circ\text{C}$ | P_D | 1.5 | |
| | $T_A=70^\circ\text{C}$ | | 1 | |
| Operating Junction and Storage Temperature Range | | T_J, T_{stg} | -55~+150 | °C |
| Steady State Thermal Resistance, Junction-to-Ambient | *a | $R_{\theta JA}$ | 81 | °C/W |



Electrical Characteristics ($T_A=25^\circ\text{C}$, unless otherwise specified)

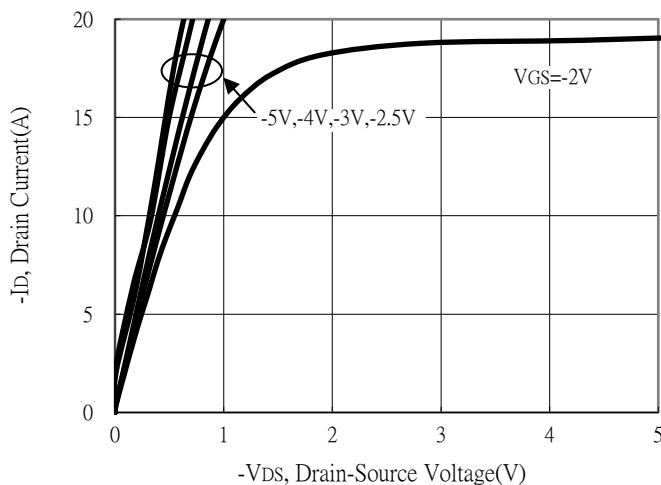
| Symbol | Min. | Typ. | Max. | Unit | Test Conditions | |
|-----------------------------------|------|-------|-----------|---------------|--|--|
| Static | | | | | | |
| BV_{DSS} | -20 | - | - | V | $\text{V}_{\text{GS}}=0\text{V}, \text{I}_D=-250\mu\text{A}$ | |
| $\text{V}_{\text{GS}(\text{th})}$ | -0.4 | - | -1.2 | | $\text{V}_{\text{DS}}=\text{V}_{\text{GS}}, \text{I}_D=-250\mu\text{A}$ | |
| G_{FS} | - | 9 | - | S | $\text{V}_{\text{DS}}=-10\text{V}, \text{I}_D=-4\text{A}$ | |
| I_{GSS} | - | - | ± 100 | nA | $\text{V}_{\text{GS}}=\pm 8\text{V}, \text{V}_{\text{DS}}=0\text{V}$ | |
| I_{DSS} | - | - | -1 | μA | $\text{V}_{\text{DS}}=-16\text{V}, \text{V}_{\text{GS}}=0\text{V}$ | |
| $\text{R}_{\text{DS}(\text{ON})}$ | - | 30 | 40 | m Ω | $\text{V}_{\text{GS}}=-4.5\text{V}, \text{I}_D=-4\text{A}$ | |
| | - | 42 | 58 | | $\text{V}_{\text{GS}}=-2.5\text{V}, \text{I}_D=-2\text{A}$ | |
| Dynamic | | | | | | |
| C_{iss} | - | 1150 | - | pF | $\text{V}_{\text{DS}}=-10\text{V}, \text{V}_{\text{GS}}=0\text{V}, f=1\text{MHz}$ | |
| C_{oss} | - | 120 | - | | | |
| C_{rss} | - | 105 | - | | | |
| R_g | - | 40 | - | Ω | $f=1\text{MHz}$ | |
| Q_g *c,d | - | 14 | - | nC | $\text{V}_{\text{DS}}=-10\text{V}, \text{I}_D=-4\text{A}, \text{V}_{\text{GS}}=-4.5\text{V}$ | |
| Q_{gs} *c,d | - | 1.7 | - | | | |
| Q_{gd} *c,d | - | 3.5 | - | | | |
| $t_{\text{d}(\text{ON})}$ *c,d | - | 5 | - | ns | $\text{V}_{\text{DS}}=-10\text{V}, \text{I}_D=-4\text{A}, \text{V}_{\text{GS}}=-4.5\text{V}, \text{R}_{\text{GS}}=1\Omega$ | |
| t_r *c,d | - | 17 | - | | | |
| $t_{\text{d}(\text{OFF})}$ *c,d | - | 112 | - | | | |
| t_f *c,d | - | 145 | - | | | |
| Source-Drain Diode | | | | | | |
| V_{SD} *c | - | -0.85 | -1.2 | V | $I_s=-4\text{A}, \text{V}_{\text{GS}}=0\text{V}$ | |
| t_{rr} | - | 68 | - | ns | $I_f=-2\text{A}, di/dt=100\text{A}/\mu\text{s}$ | |
| Q_{rr} | - | 62 | - | | | |

Note:

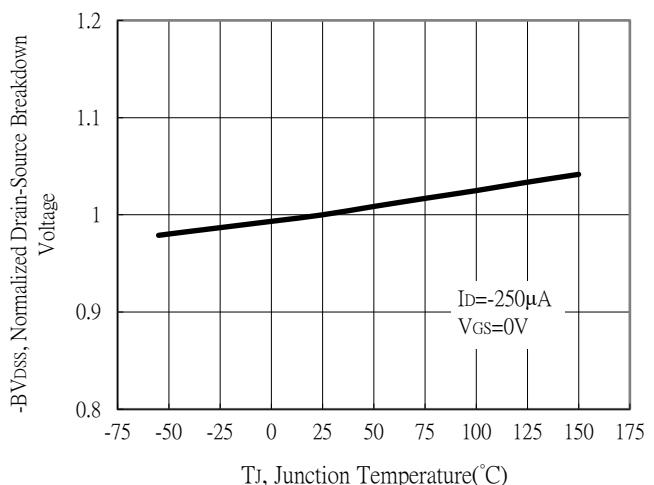
- *a. The value of R_{GJA} is measured with the device mounted on 1in² FR-4 board with 2oz copper, in a still air environment with $T_A=25^\circ\text{C}$. The power dissipation P_D is based on R_{GJA} and the maximum allowed junction temperature of 150°C . The value in any given application depends on the user's specific board design.
- *b. Repetitive rating, pulse width limited by junction temperature $T_{J(\text{MAX})}=150^\circ\text{C}$. Ratings are based on low frequency and low duty cycles to keep initial $T_J=25^\circ\text{C}$.
- *c. Pulse Test : Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$.
- *d. Independent of operating temperature.

Typical Characteristics

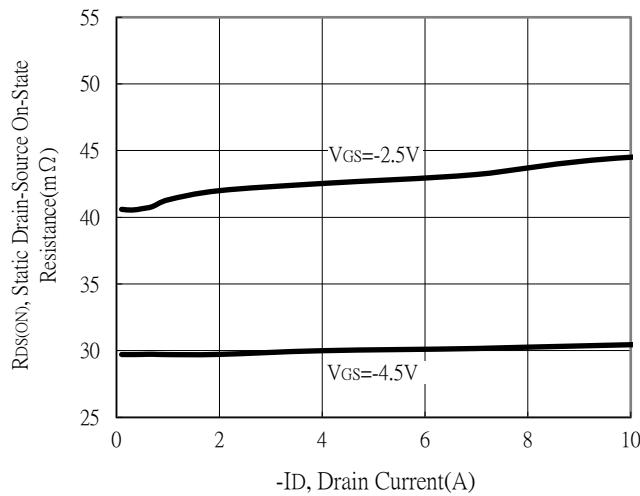
Typical Output Characteristics



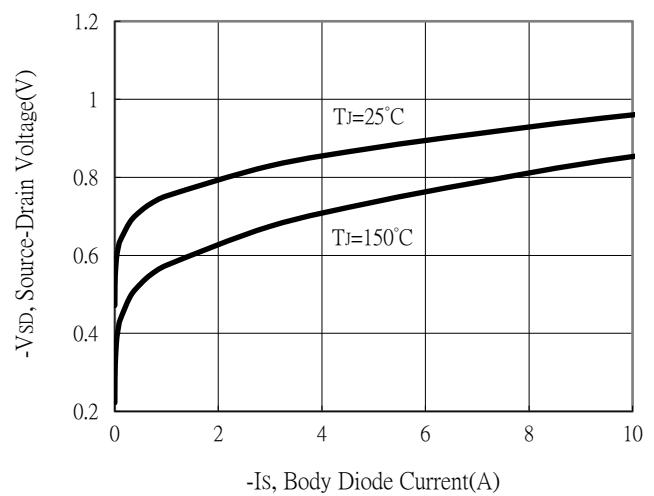
Breakdown Voltage vs Ambient Temperature



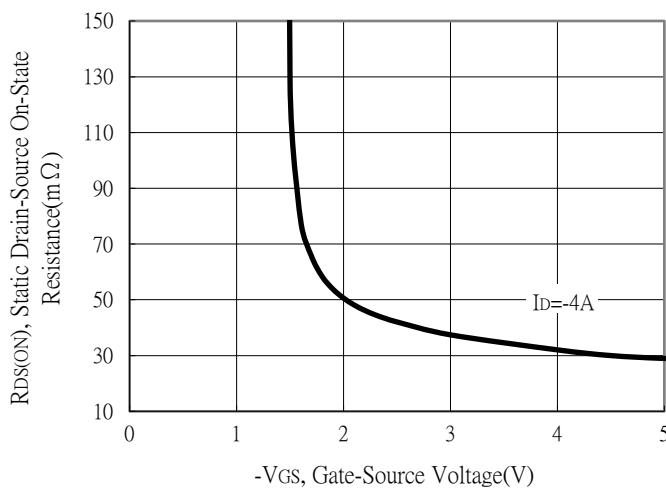
Static Drain-Source On-State resistance vs Drain Current



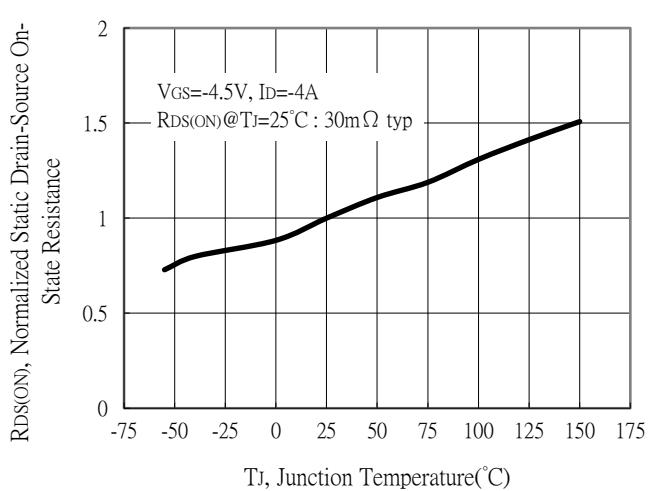
Body Diode Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

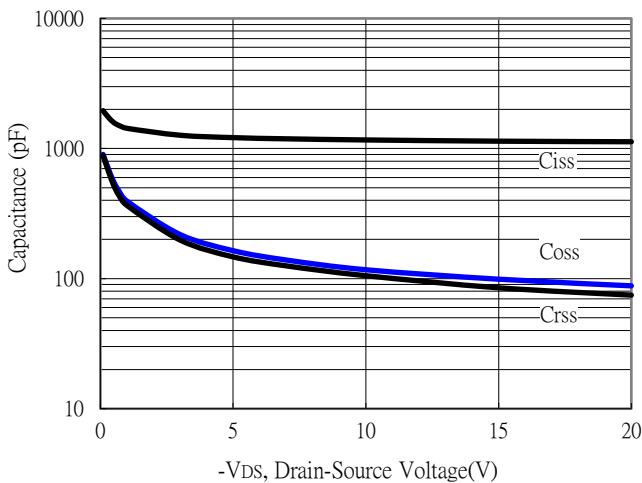


Drain-Source On-State Resistance vs Junction Temperature

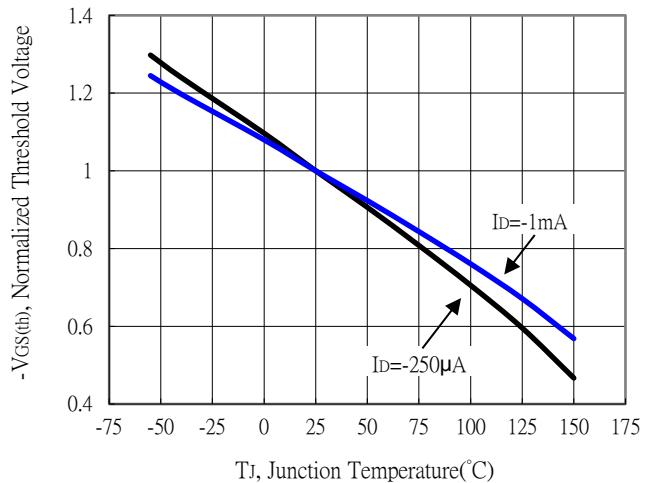


Typical Characteristics

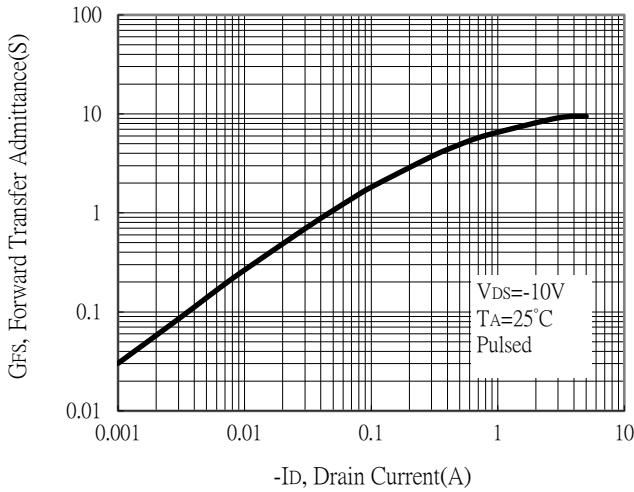
Capacitance vs Drain-to-Source Voltage



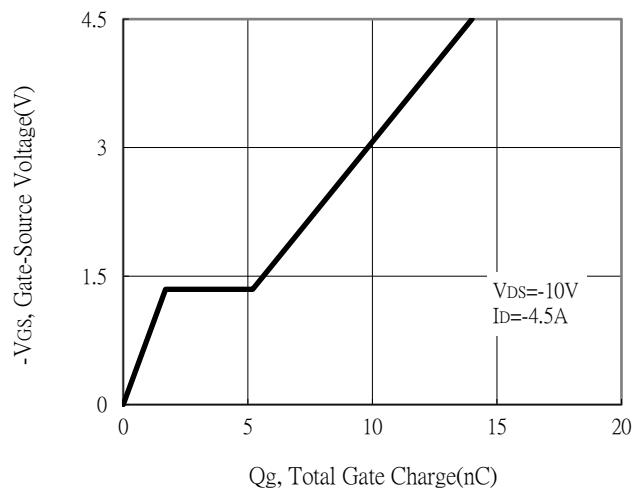
Threshold Voltage vs Junction Temperature



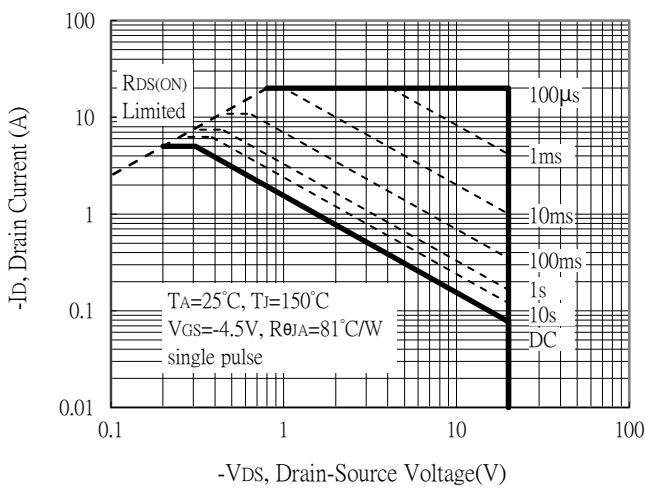
Forward Transfer Admittance vs Drain Current



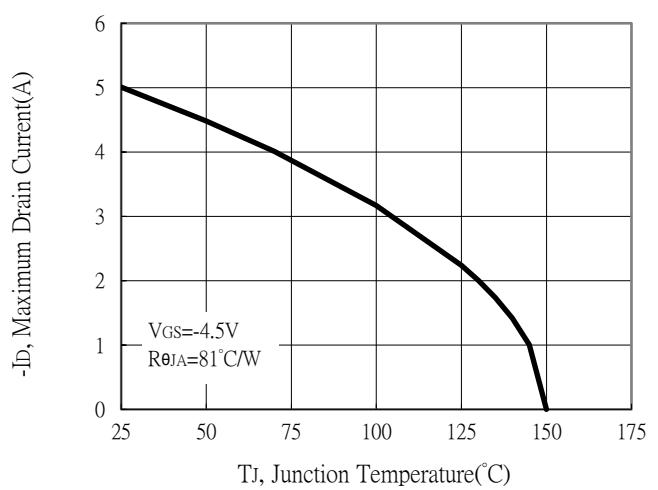
Gate Charge Characteristics



Maximum Safe Operating Area

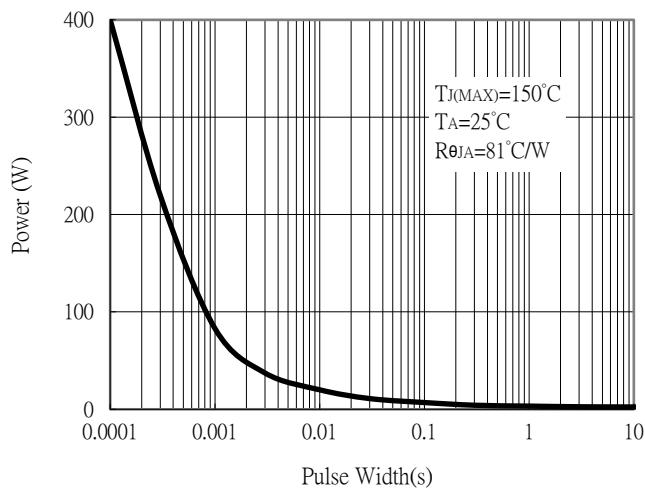


Maximum Drain Current vs Junction Temperature

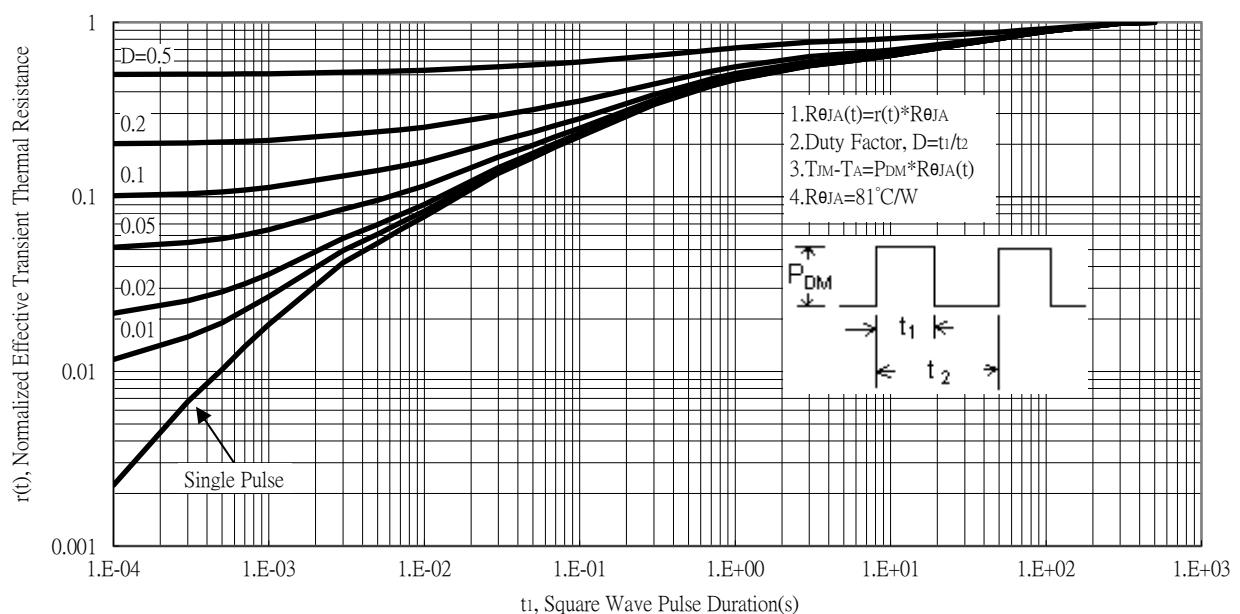


Typical Characteristics

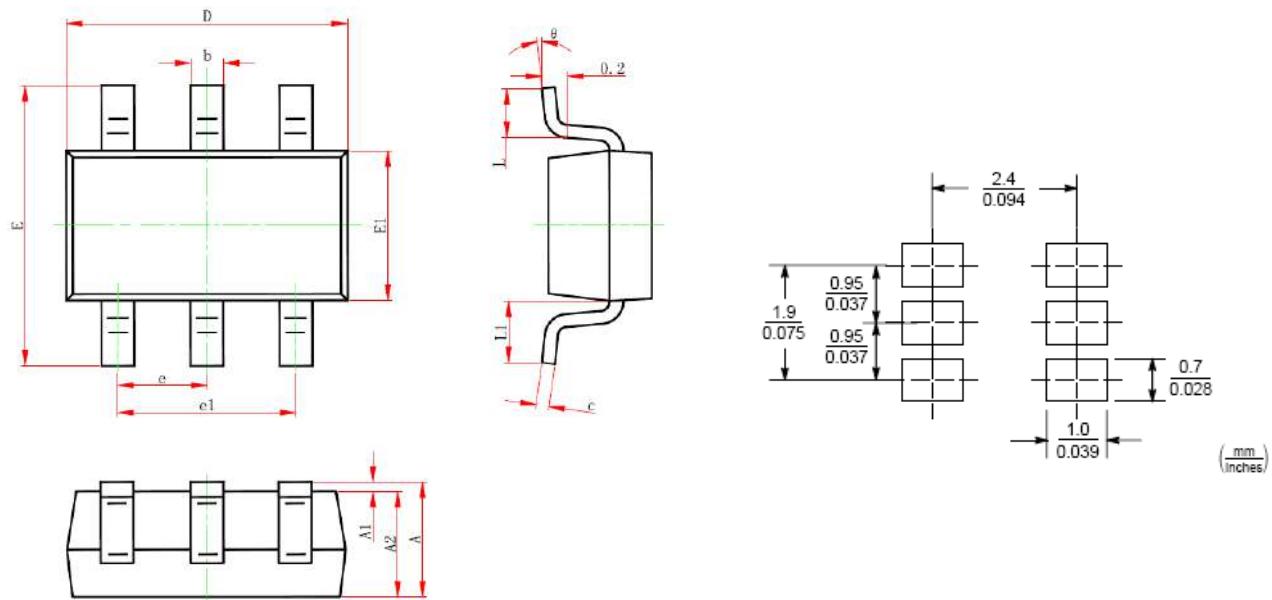
Single Pulse Power Rating, Junction to Ambient



Transient Thermal Response Curves



SOT-26 Dimension

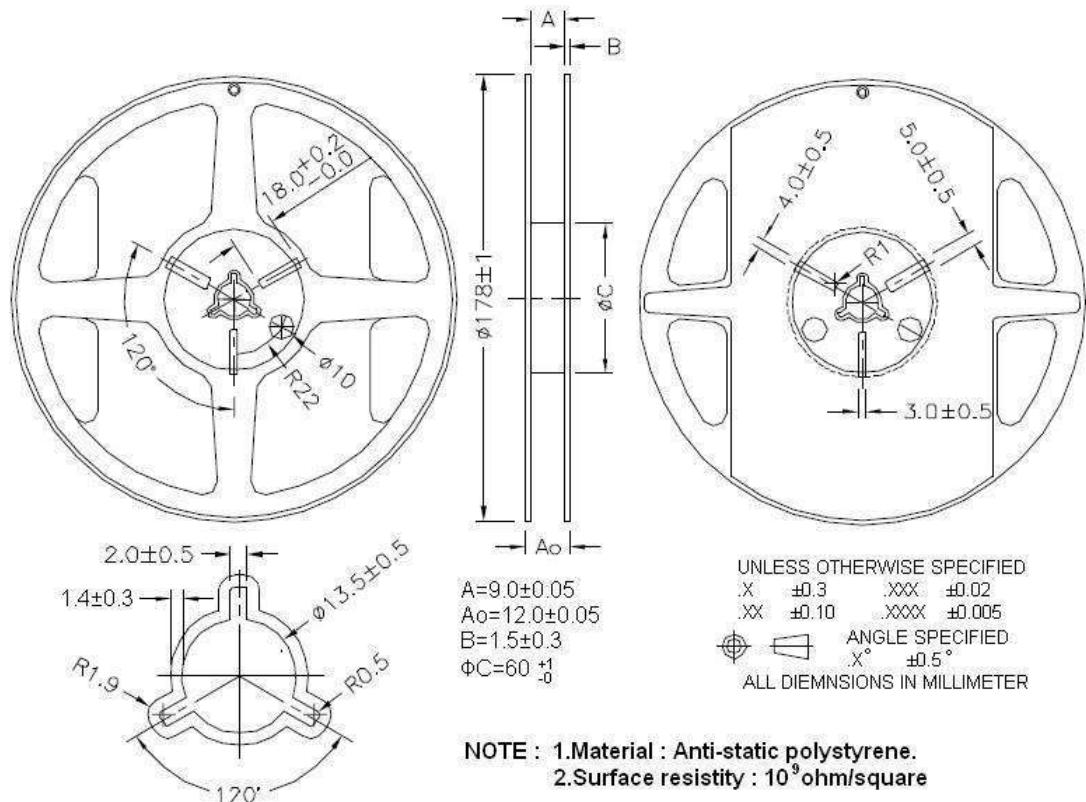


6-Lead SOT-26 Plastic Surface Mount Package

Recommended Soldering Footprint

| DIM | Inches | | Millimeters | | DIM | Inches | | Millimeters | |
|-----|--------|-------|-------------|-------|-------|--------|-------|-------------|-------|
| | Min. | Max. | Min. | Max. | | Min. | Max. | Min. | Max. |
| A | 0.041 | 0.049 | 1.050 | 1.250 | E1 | 0.104 | 0.116 | 2.650 | 2.950 |
| A1 | 0.000 | 0.004 | 0.000 | 0.100 | e | 0.037 | (BSC) | 0.950 | (BSC) |
| A2 | 0.041 | 0.045 | 1.050 | 1.150 | e1 | 0.071 | 0.079 | 1.800 | 2.000 |
| b | 0.012 | 0.020 | 0.300 | 0.500 | L | 0.012 | 0.024 | 0.300 | 0.600 |
| c | 0.004 | 0.008 | 0.100 | 0.200 | L1 | 0.024 | REF. | 0.600 | REF. |
| D | 0.111 | 0.119 | 2.820 | 3.020 | theta | 0° | 8° | 0° | 8° |
| E | 0.059 | 0.067 | 1.500 | 1.700 | | | | | |

Reel Dimension



Carrier Tape Dimension

